

Notice of References Cited

Application/Control No.

10/644,002

Applicant(s)/Patent Under
Reexamination
OIKAWA, MASAHIKO

Examiner

PAWANDEEP S. DHINGRA

Art Unit

2625

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,797,706 A	01-1989	Sugishima et al.	358/300
*	B	US-5,689,755 A	11-1997	Ataka, Hiroyuki	399/8
*	C	US-5,812,747 A	09-1998	Kayano et al.	358/1.15
*	D	US-5,809,363 A	09-1998	Kitamura et al.	399/8
*	E	US-6,192,202 B1	02-2001	Doi, Takashi	399/8
*	F	US-2001/0043360 A1	11-2001	KITAMURA et al.	358/1.15
*	G	US-6,363,230 B1	03-2002	Masai, Katsunori	399/82
*	H	US-6,384,928 B2	05-2002	Nagasawa et al.	358/1.15
*	I	US-6,618,166 B1	09-2003	Suzue, Tadashi	358/1.15
*	J	US-6,625,406 B2	09-2003	Suzuki et al.	399/75
*	K	US-7,167,256 B1	01-2007	Koike et al.	358/1.15
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 08-116429	05-1996	Japan	Koike et al.	H04N 1/36
*	O	JP 2000-358127	12-2000	Japan	Mori et al.	H04N 1/00
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.